**TOSHIBA** 2SJ507

TOSHIBA FIELD EFFECT TRANSISTOR SILICON P CHANNEL MOS TYPE ( $L^2-\pi$ -MOS V)

# 2 S J 5 0 7

HIGH SPEED, HIGH CURRENT SWITCHING APPLICATIONS CHOPPER REGULATOR, DC-DC CONVERTER AND MOTOR DRIVE **APPLICATIONS** 

#### 4V Gate Drive

Low Drain-Source On Resistance :  $R_{DS(ON)} = 0.5\Omega$  (Typ.)

High Forward Transfer Admittance :  $|Y_{fs}| = 1.0S$  (Typ.)

Low Leakage Current :  $I_{DSS} = -100 \mu A \text{ (Max.)} \text{ (V}_{DS} = -60 \text{ V)}$ 

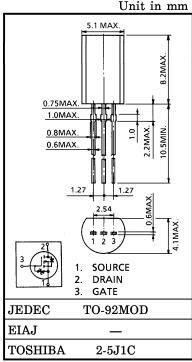
:  $V_{th} = -0.8 \sim -2.0 V$ Enhancement-Mode

 $(V_{DS} = -10V, I_D = -1mA)$ 

#### MAXIMUM RATINGS (Ta = 25°C)

CHARACTERI	SYMBOL	RATING	UNIT	
Drain-Source Voltage	$ m v_{DSS}$	-60	V	
Drain-Gate Voltage (R	$v_{ m DGR}$	-60	V	
Gate-Source Voltage	$v_{GSS}$	±20	V	
Drain Current	DC	$I_{\mathbf{D}}$	-1	A
Drain Current	Pulse	$I_{ m DP}$	-3	A
Drain Power Dissipation	$P_{\mathrm{D}}$	0.9	W	
Single Pulse Avalanch	$\mathrm{E}_{\mathrm{AS}}$	249.6	mJ	
Avalanche Current	$I_{ m AR}$	-1	Α	
Repetitive Avalanche I	${ m E_{AR}}$	0.09	mJ	
Channel Temperature	$\mathrm{T_{ch}}$	150	°C	
Storage Temperature F	$\mathrm{T_{stg}}$	-55~150	$^{\circ}\mathrm{C}$	

#### INDUSTRIAL APPLICATIONS



Weight: 0.36g (Typ.)

#### THERMAL CHARACTERISTICS

CHARACTERISTIC	SYMBOL	MAX.	UNIT
Thermal Resistance, Channel to Ambient	R <sub>th (ch-a)</sub>	138	°C/W

#### Note;

- Repetitive rating; Pulse Width Limited by Max. junction temperature.
- $V_{DD} = -25V$ , Starting  $T_{ch} = 25^{\circ}C$ , L = 339mH,  $R_{G} = 25\Omega$ ,  $I_{AR} = -1A$

This transistor is an electrostatic sensitive device. Please handle with caution.

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## ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARA	ACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakag	ge Current	$I_{ m GSS}$	$V_{GS} = \pm 16V, V_{DS} = 0V$	T —	_	±10	$\mu$ A
Drain Cut-o	ff Current	$I_{ m DSS}$	$V_{DS} = -60V, V_{GS} = 0V$	T —	_	-100	$\mu$ A
Drain-Source Voltage	e Breakdown	V (BR) DSS	$I_D = -10 \text{mA}, V_{GS} = 0 \text{V}$	-60	_	_	V
Gate Thresh	old Voltage	$v_{th}$	$V_{DS} = -10V, I_{D} = -1mA$	-0.8	_	-2.0	V
Drain-Source	e ON Resistance	R <sub>DS</sub> (ON)	$V_{GS} = -4V, I_D = -0.5A$ $V_{GS} = -10V, I_D = -0.5A$		0.72	1.0	Ω
Forward Tra Admittance	ınsfer	Y <sub>fs</sub>	$V_{DS} = -10V, I_D = -0.5A$	0.5	1.0	_	s
Input Capacitance		$\mathrm{c}_{\mathrm{iss}}$		_	170	_	
Reverse Transfer Capacitance		$C_{rss}$	$V_{ m DS} = -10  m V, \ V_{ m GS} = 0  m V, \ f = 1  m MHz$	_	25	_	pF
Output Capacitance		Coss			72	_	
Switching Time	Rise Time	$t_{\mathbf{r}}$	$V_{GS}$ $V_{OUT}$ $V_{OUT}$ $V_{OUT}$ $V_{OUT}$ $V_{OUT}$ $V_{OUT}$	_	20	_	
	Turn-on Time	t <sub>on</sub>	$-10V$ $R_{L}=60\Omega$	_	35	_	ns
	Fall Time	tf	_	_	30	_	lis
	Turn-off Time	t <sub>off</sub>	$V_{\mathrm{IN}}: t_{\mathrm{r}}, t_{\mathrm{f}} < 5 \mathrm{ns},  V_{\mathrm{DD}} = -30 \mathrm{V}$ $\mathrm{Duty} \leq 1\%, t_{\mathrm{w}} = 10 \mu \mathrm{s}$		135		
Total Gate Charge (Gate- Source Plus Gate-Drain)		$\mathbf{Q}_{\mathbf{g}}$	$V_{DD} = -48V, V_{GS} = -10V,$	_	5.6	_	nC
Gate-Source Charge		$\mathbf{Q}_{\mathbf{g}\mathbf{s}}$	$I_D = -1A$		3.9	_	l nc
Gate-Drain ("Miller") Charge		$\mathbf{Q}_{\mathbf{gd}}$		—	1.7	_	

# SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Continuous Drain Reverse Current	$I_{ m DR}$	_	_	_	-1	A
Pulse Drain Reverse Current	$I_{ m DRP}$	_	_	_	-3	A
Diode Forward Voltage	$v_{ m DSF}$	$I_{DR} = -1A, V_{GS} = 0V$	_	_	1.5	V
Reverse Recovery Time	$ m t_{rr}$	$I_{DR} = -1A$ , $V_{GS} = 0V$		58	_	ns
Reverse Recovery Charge	$Q_{rr}$	$ m dI_{DR}$ / $ m dt$ = 50A / $ m \mu s$	_	72.5	_	nC

## MARKING

